

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/833,986	CHANG, YONG	
Examiner		Art Unit		Page 1 of 3
Jamal A. Fox		2664		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,134,434	10-2000	Krishnamurthi et al.	455/419
*	B	US-6,633,554	10-2003	Dalal, Neerav N.	370/331
*	C	US-6,628,632	09-2003	Dolan, Michael F.	370/332
*	D	US-6,360,100	03-2002	Grob et al.	455/442
*	E	US-5,901,354	05-1999	Menich et al.	455/442
*	F	US-6,198,929	03-2001	Krishnamurthi et al.	455/439
*	G	US-6,625,198	09-2003	Tiedemann et al.	375/130
*	H	US-6,430,200	08-2002	Han et al.	370/500
*	I	US-6,766,168	07-2004	Lim, Byung Keun	455/435.1
*	J	US-5,533,014	07-1996	Willars et al.	370/335
*	K	US-5,697,055	12-1997	Gilhousen et al.	455/436
*	L	US-5,848,063	12-1998	Weaver et al.	370/331
*	M	US-5,917,811	06-1999	Weaver et al.	370/332

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/833,986	CHANG, YONG	
Examiner		Art Unit		Page 2 of 3
Jamal A. Fox		2664		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,926,470	07-1999	Tiedemann, Jr., Edward G.	370/334
*	B	US-6,542,743	04-2003	Soliman, Samir S.	455/436
*	C	US-6,134,444	10-2000	Kotzin, Michael D.	455/453
*	D	US-6,075,989	06-2000	Moore et al.	455/436
*	E	US-5,722,074	02-1998	Muszynski, Peter	455/442
*	F	US-6,771,963	08-2004	Cheng et al.	455/437
*	G	US-6,611,507	08-2003	Hottinen et al.	370/331
*	H	US-6,549,524	04-2003	Shin, Yeong Jong	370/331
*	I	US-6,366,778	04-2002	Bender et al.	455/442
*	J	US-6,320,855	11-2001	Shi, Yu	370/332
*	K	US-6,078,570	06-2000	Czaja et al.	370/331
*	L	US-6,075,990	06-2000	Shin, Yeong-Jong	455/440
*	M	US-6,009,328	12-1999	Muszynski, Peter	455/442

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/833,986	CHANG, YONG	
Examiner		Art Unit		Page 3 of 3
Jamal A. Fox		2664		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,937,019	08-1999	Padovani, Roberto	375/358
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.